

**Search Notes**

Application/Control No.

10/606,591

Examiner

Le Nguyen

Applicant(s)/Patent under  
Reexamination

EVANS ET AL.

Art Unit

2174

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
consulted w/Ba Huynh regarding local process versus remote process	7/30/2007	LVN
updated search (US-PGPub; USPAT: 715/778,740-743,745)	7/30/2007	LVN